TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC7MBL3245CFT, TC7MBL3245CFK, TC7MBL3245CFTG

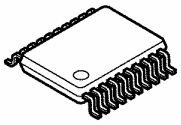
Low Voltage/Low Capacitance Octal Bus Switch

The TC7MBL3245C is a Low Voltage/Low Capacitance CMOS 8bit Bus Switch. The low on-resistance of the switch allows connections to be made with minimal propagation delay time.

The TC7MBL3245C requires the output enable ($\overline{OE}$) input to be set high to place the output into the high impedance.

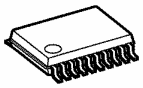
All inputs are equipped with protection circuits against static discharge.

TC7MBL3245CFT



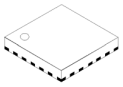
TSSOP20-P-0044-0.65A

TC7MBL3245CFK



VSSOP20-P-0030-0.50

TC7MBL3245CFTG



VQON20-P-0404-0.50

Features

- Operating voltage : V_{CC} = 1.65 to 3.6 V
- On-capacitance : $C_{I/O}$ = 7.5pF Switch On (typ.)@V_{CC}= 3 V
- On-resistance : R_{ON} = 6.5 Ω (typ.)@V_{CC}=3 V, VI/O= 0 V
- ESD performance : Machine model ≥ ±200 V
  Human body model ≥ ±2000 V
- Power-down protection for inputs ($\overline{OE}$ and I/O)
- Package: TSSOP20,VSSOP20 (US20), VQON20
- Pin compatible with the TC7MBL3245A,B,S

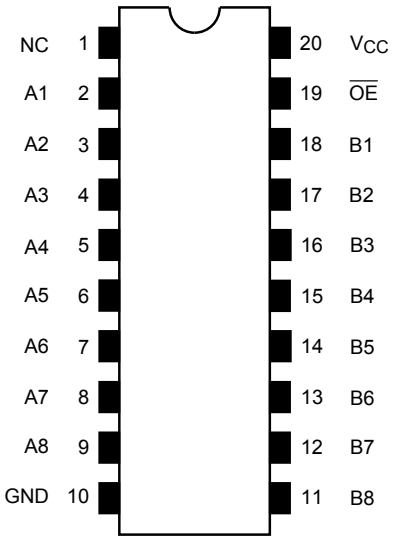
Note: When mounting VQON package, the type of recommended flux is RA or RMA.

Weight

TSSOP20-P-0044-0.65A	: 0.08 g (typ.)
VSSOP20-P-0030-0.50	: 0.03 g (typ.)
VQON20-P-0404-0.50	: 0.0145g (typ.)

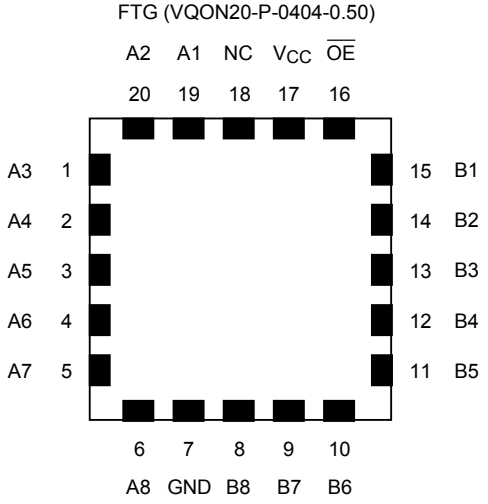
Pin Assignment (top view)

FT (TSSOP20-P-0044-0.65A)
FK (VSSOP20-P-0030-0.50)



NC-No Internal Connection

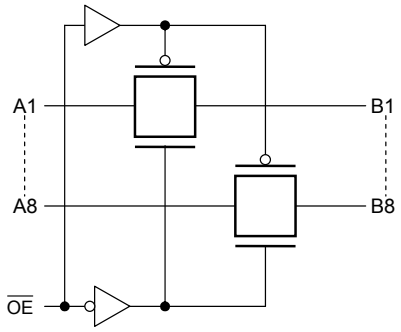
FTG (VQON20-P-0404-0.50)



Truth Table

Inputs $\overline{OE}$	Function
L	A port = B port
H	Disconnect

System Diagram



Absolute Maximum Ratings (Note)

Characteristic		Symbol	Rating	Unit
Power supply range		V_{CC}	−0.5 to 4.6	V
Control pin input voltage $\overline{OE}$		V_{IN}	−0.5 to 4.6	V
Switch terminal I/O voltage	V_{CC}=0V or Switch=Off	V_S	−0.5 to 4.6	V
	Switch=On	V_S	−0.5 to V_{CC}+0.5	
Clump diode current		I_{IK}	−50	mA
Switch I/O current		I_S	50	mA
Power dissipation		P_D	180	mW
DC V_{CC}/GND current		I_{CC}/I_{GND}	±100	mA
Storage temperature		T_{stg}	−65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction
Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook (“Handling Precautions”/“Derating Concept and Methods”) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Operating Ranges (Note)

Note:

Characteristic		Symbol	Rating	Unit
Power supply voltage		V_{CC}	1.65 to 3.6	V
Control pin input voltage $\overline{OE}$		V_{IN}	0 to 3.6	V
Switch terminal I/O voltage	V_{CC}=0V or Switch=Off	V_S	0 to 3.6	V
	Switch=On	V_S	0 to V_{CC}	
Operating temperature		T_{opr}	−40 to 85	°C
Input rise and fall time		dt/dv	0 to 10	ns/V

The operating ranges must be maintained to ensure the normal operation of the device.

Unused inputs must be tied to either V_{CC} or GND.

Electrical Characteristics

DC Characteristics (Ta = –40 to 85°C)

Parameter		Symbol	Test Condition	V_{CC} (V)	Min	Typ.	Max	Unit
Input voltage $\overline{OE}$	"H" level	V_{IH}	—	1.65 to 3.6	0.7 × V_{CC}	—	—	V
	"L" level	V_{IL}	—	1.65 to 3.6	—	—	0.3 × V_{CC}	
Input leakage current $\overline{OE}$		I_{IN}	V_{IN} = 0 to 3.6 V	1.65 to 3.6	—	—	±1.0	μA
Power-off leakage current		I_{OFF}	$\overline{OE}$,A,B = 0 to 3.6 V	0	—	—	10	μA
Off-state leakage current (switch off)		I_{SZ}	A, B = 0 to V_{CC}, $\overline{OE}$ = V_{CC}	1.65 to 3.6	—	—	±1.0	μA
On resistance (Note2)		R_{ON}	V_{IS} = 0 V, I_{IS} = 30 mA (Note1)	3.0	—	6.5	11	Ω
			V_{IS} = 3.0 V, I_{IS} = 30 mA (Note1)	3.0	—	11	16	
			V_{IS} = 2.4V, I_{IS} = 15 mA (Note1)	3.0	—	12	18	
			V_{IS} = 0 V, I_{IS} = 24 mA (Note1)	2.3	—	7	11	
			V_{IS} = 2.3 V, I_{IS} = 24 mA (Note1)	2.3	—	13	20	
			V_{IS} = 2.0V, I_{IS} = 15 mA (Note1)	2.3	—	15	21	
			V_{IS} = 0 V, I_{IS} = 4 mA (Note1)	1.65	—	8	14	
			V_{IS} = 1.65 V, I_{IS} = 4 mA (Note1)	1.65	—	17	26	
Quiescent supply current		I_{CC}	V_{IN} = V_{CC} or GND, I_{OUT} = 0	3.6	—	—	10	μA

Note1: All typical values are at Ta=25°C.

Note2: Measured by the voltage drop between A and B pins at the indicated current through the switch. On resistance is determined by the lower of the voltages on the two (A or B) pins

AC Characteristics (Ta = –40 to 85°C)

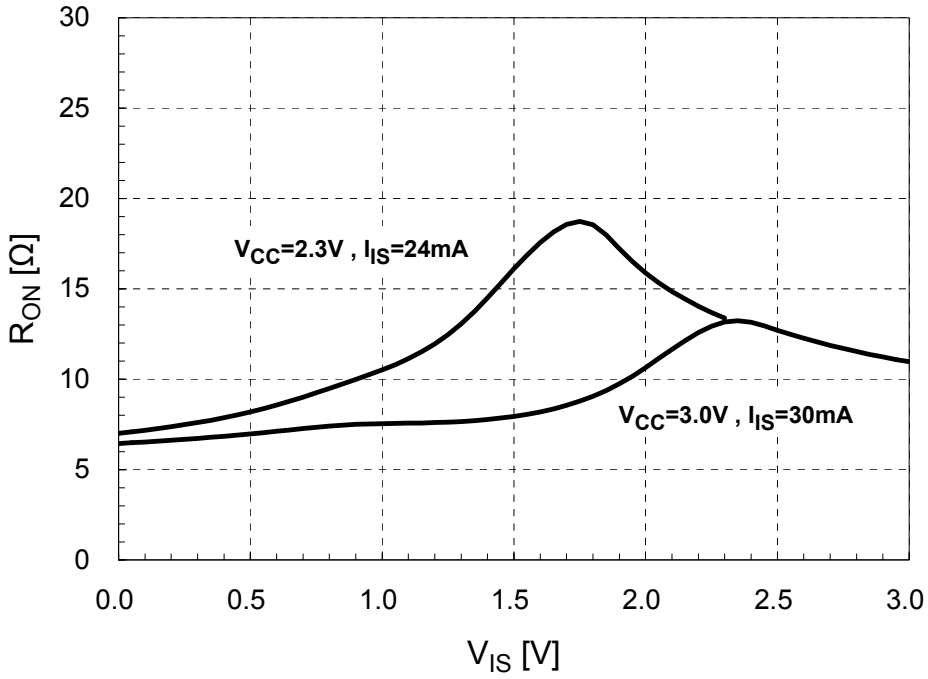
Characteristics	Symbol	Test Condition	V_{CC} (V)	Min	Max	Unit
Output enable time	t_{pZL} t_{pZH}	Figure 1, Figure 2	3.3 ± 0.3	—	6	ns
			2.5 ± 0.2	—	7	
			1.8 ± 0.15	—	11	
Output disable time	t_{pLZ} t_{pHZ}	Figure 1, Figure 2	3.3 ± 0.3	—	6	ns
			2.5 ± 0.2	—	7	
			1.8 ± 0.15	—	11	

Capacitive Characteristics (Ta = 25°C)

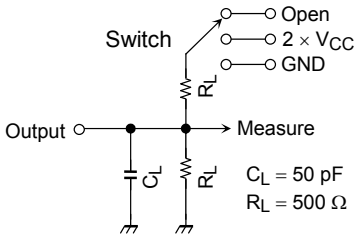
Characteristics	Symbol	Test Condition	V_{CC} (V)	Typ.	Unit
Control pin input capacitance	C_{IN}	V_{IN} = 0 V (Note)	3.0	4	pF
Switch terminal capacitance (Switch Off)	$C_{I/O}$	$\overline{OE}$ = V_{CC}, V_{IS} = 0 V (Note)	3.0	3.5	pF
Switch terminal capacitance (Switch On)	$C_{I/O}$	$\overline{OE}$ = GND, V_{IS} = 0 V (Note)	3.0	7.5	pF

Note: This parameter is guaranteed by design

R_{ON} - V_{IS} Characteristic (typ.) Ta = 25°C



AC Test Circuit



Parameter	Switch
t_{pLZ}, t_{pZL}	2 × V_{CC}
t_{pHZ}, t_{pZH}	GND

Figure 1

AC Waveform

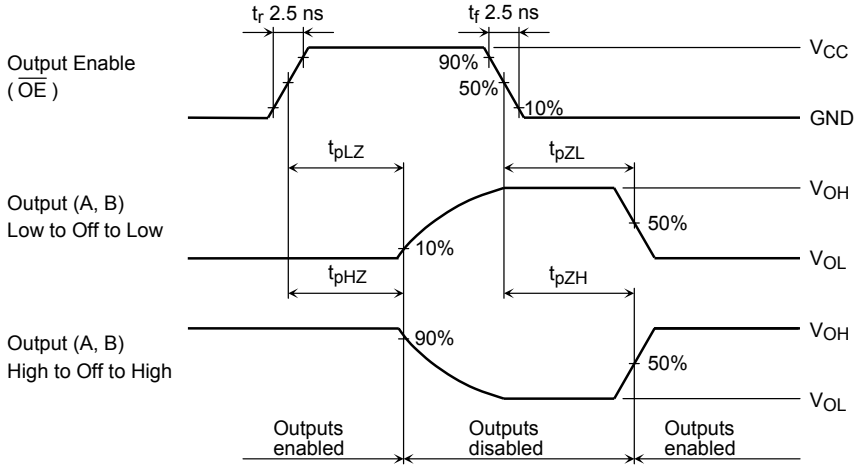


Figure 2 t_{pLZ}, t_{pHZ}, t_{pZL}, t_{pZH}

Rise and Fall Times (tr / tf) of the TC7MBL3245C I/O Signals

The tr(out) and tf(out) values of the output signals are affected by the CR time constant of the input, which consists of the switch terminal capacitance ($C_{I/O}$) and the on-resistance (R_{ON}) of the input.

In practice, the tr(out) and tf(out) values are also affected by the circuit's capacitance and resistance components other than those of the TC7MBL3245C.

The tr(out) / tf(out) values can be approximated as follows. (Figure 3 shows the test circuit.)

$$tr(out) / tf(out)\ (approx) = -(C_{I/O} + C_L) \cdot (R_{DRIVE} + R_{ON}) \cdot \ln(((V_{OH} - V_{OL}) - V_M) / (V_{OH} - V_{OL}))$$

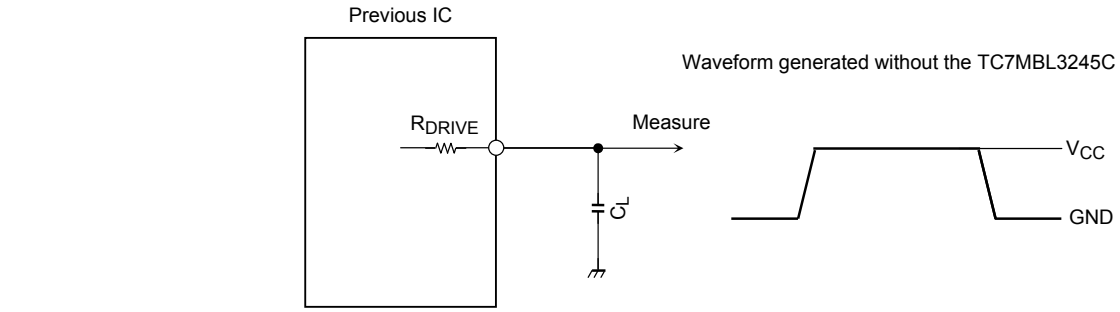
where, R_{DRIVE} is the output impedance of the previous-stage circuit.

Calculation example:

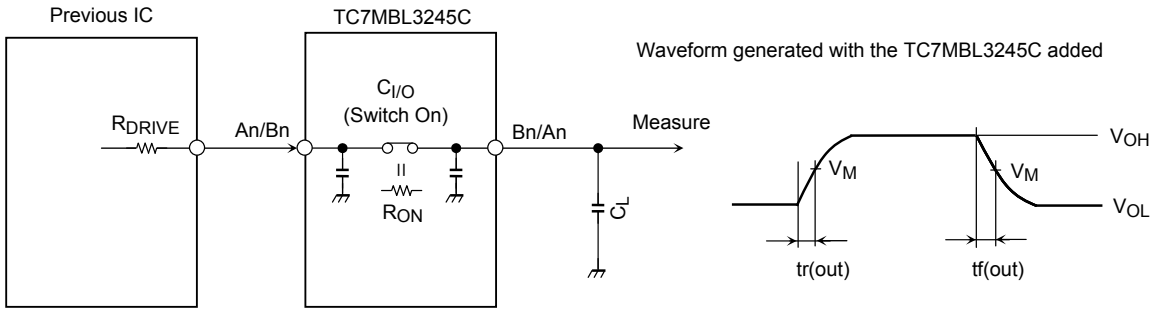
$$tr(out)\ (approx) = -(7.5 + 15)E\text{-}12 \cdot (120 + 6.5) \cdot \ln(((3.0 - 0) - 1.5) / (3.0 - 0))$$
$$\approx 2.0\ ns$$

Calculation conditions:

V_{CC} = 3.0V , C_L = 15pF , R_{DRIVE} = 120Ω(output impedance of the previous IC), V_M = 1.5V (V_{CC} / 2)
Output of the previous IC = digital (i.e., high-level voltage = V_{CC}; low-level voltage = GND)



R_{DRIVE} = output impedance of the previous IC



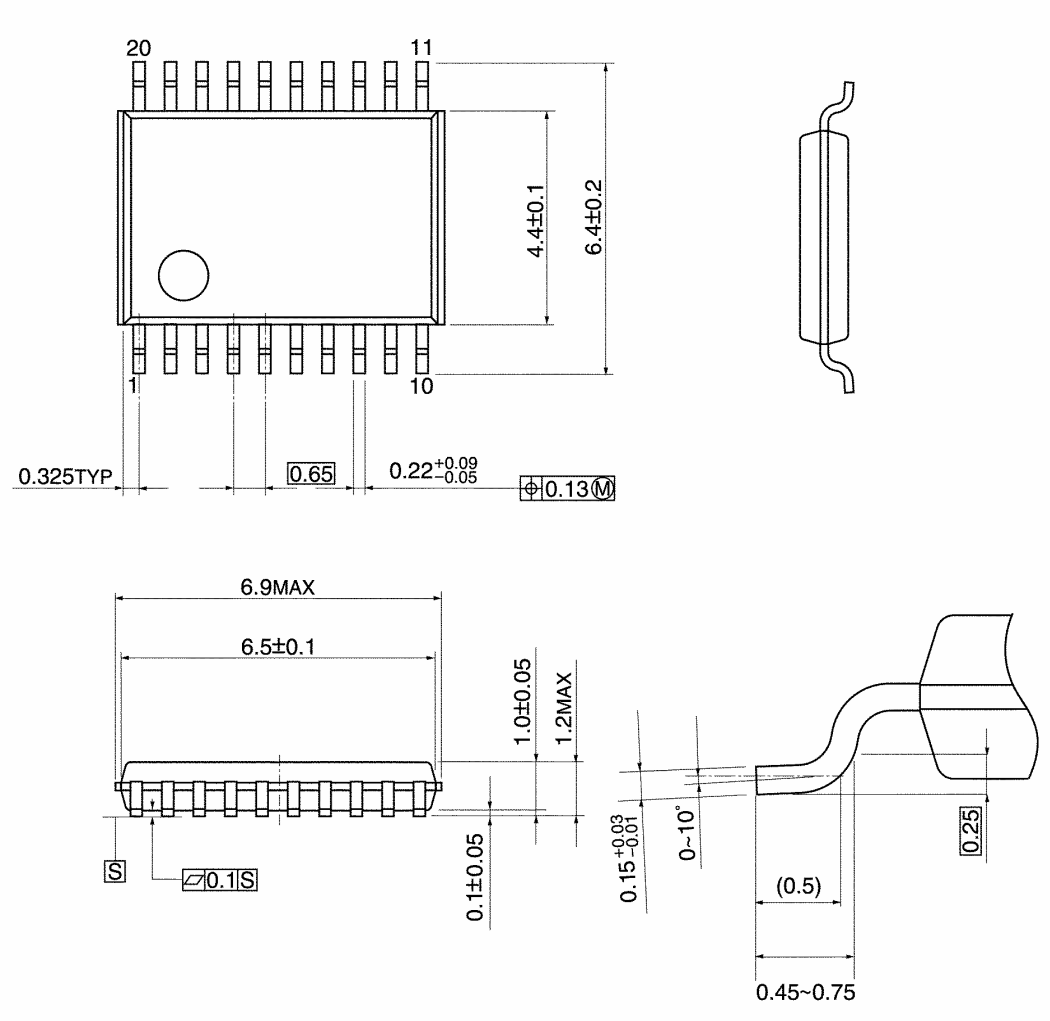
R_{DRIVE} = output impedance of the previous IC

項目	V_{CC}		
	3.3 ± 0.3 V	2.5 ± 0.2 V	1.8 ± 0.15 V
V_M	V_{CC} / 2	V_{CC} / 2	V_{CC} / 2

Figure 3 Test Circuit

Package Dimensions

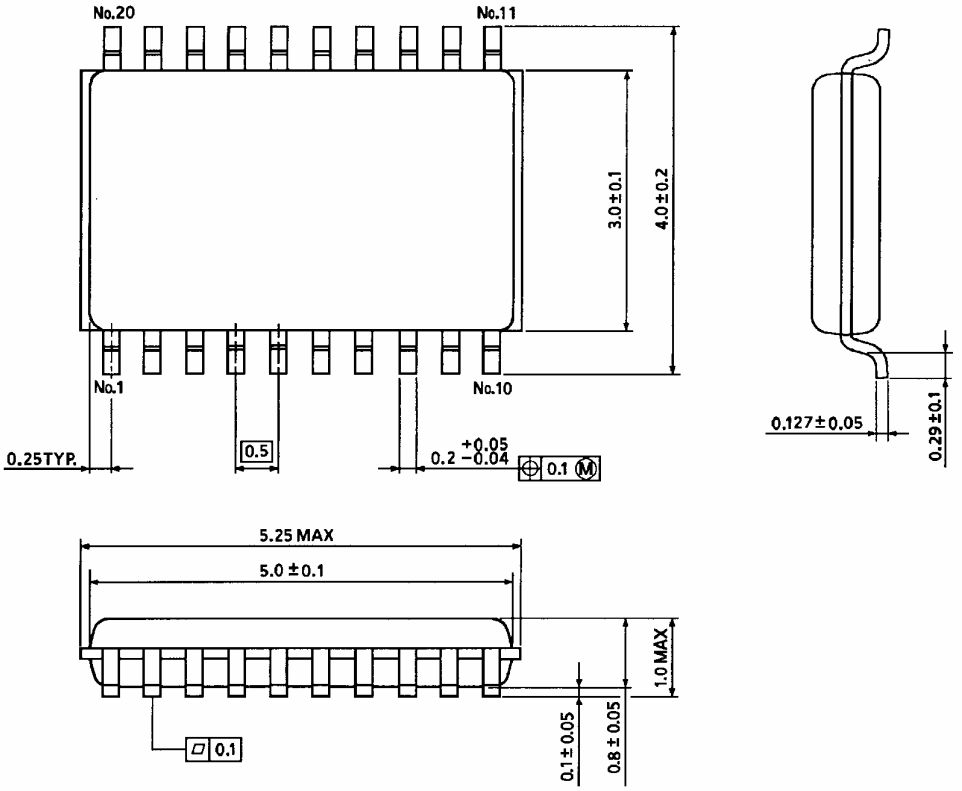
TSSOP20-P-0044-0.65A Unit: mm



Weight: 0.08 g (typ.)

Package Dimensions

VSSOP20-P-0030-0.50 Unit : mm

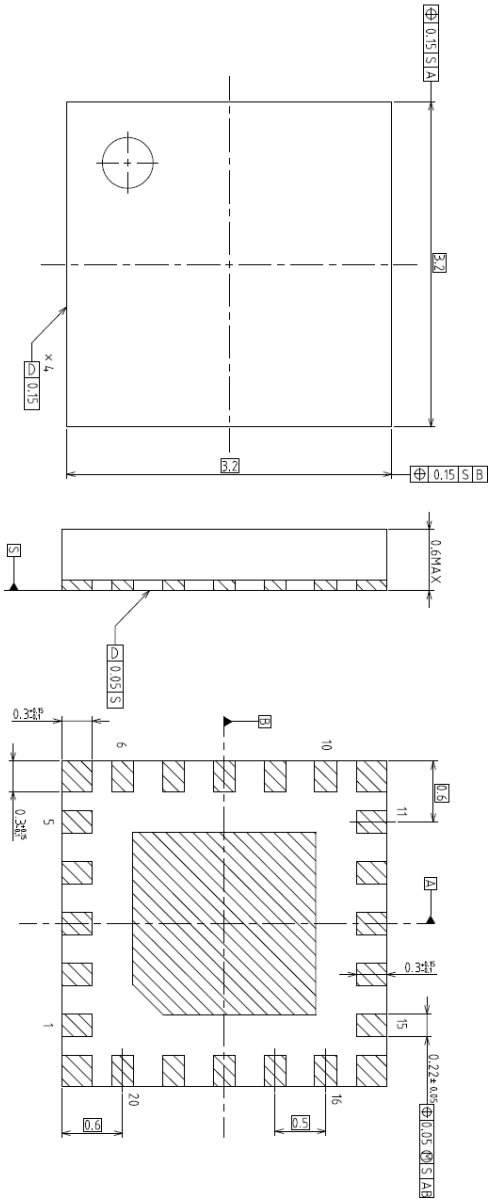


Weight: 0.03 g (typ.)

Package Dimensions

VQON20-P-0404-0.50

Unit : mm



Weight: 0.0145 g (typ.)

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20070701-EN GENERAL

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